Applicant(s)/Patent Under Application/Control No. Reexamination 10/660,517 CHANG, SHU-MEI Notice of References Cited Art Unit Examiner Page 1 of 1 Alan S. Chen 2182 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 455/556.1 10-2004 Yen et al. US-2004/0198429 A1 Α 710/305 US-2003/0163626 A1 08-2003 Chen et al. Wu, Wen-Jen 455/066.1 US-2004/0203415 A1 10-2004 С D US-US-Ε US-F US-G US-USı US-US-Κ US-L US-FOREIGN PATENT DOCUMENTS Date Document Number Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 P Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х